

<b>Notice of References Cited</b>	Application/Control No. 10/085,165	Applicant(s)/Patent Under Reexamination YAMAGUCHI ET AL.	
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**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-2001/0014862	08-2001	Hatanaka et al.	704/500
	B	US-6,816,870	11-2004	Nishimura et al.	707/104.1
	C	US-			
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	K	US-			
	L	US-			
	M	US-			

**FOREIGN PATENT DOCUMENTS**

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**NON-PATENT DOCUMENTS**

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